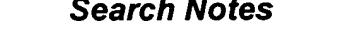


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/666,462	STONE ET AL.
	Examiner Hae M. Hyeon	Art Unit 2839

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner